FORM PTO 1449 (modified)				ATTY DOCKET NO. 169.1644	APPLICATION NO. 09/805,877		
U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE  LIST OF REFERENCES CITED BY APPLICANT(S)				APPLICANT DOMINIC YIP			
(Use several sheets if necessary)				FILING DATE March 15, 2001		GROUP 2621	
U.S. PATENT DOCUMENTS							
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\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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